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Verification of AMBA AHB Protocol using UVM

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Abstract— The project aims to verify the AMBA AHB protocol by using universal verification methodology is presented in this paper. Advanced high-performance(AHB) is used for communication of on chip bus which support single clock edge operation wider data 32/64/128 bit can be supported. The new verification constructs can be easily reused for the objectedoriented feature of universal verification methodology (UVM). Verification IP is the one which provides a smart way to verify the AHB Components. The advanced verification testbench incorporates the illustrations regarding simulation result are analysed to evaluate the effectiveness of the proposed testbench and functional coverage is to check functionality of the design. The self-checking mechanism using assertions improves the quality of UVM check by shortening time to debug and reducing time to cover for the in-depth understanding of test case output. Keywords— AMBA, AHB, UVM, functional coverage, assertion

I. INTRODUCTION

The tremendous progress of the VLSI Technology enables the integration of more than several million transistors in a single chip to make a system-on-chip this has made verification the most critical bottleneck of the chip design flow roughly 70 to 75 percent of the design is spent in verification. verification is the process of determining whether a system conforms to its specification the process should provide evidence that a system behaves like intended by its functionality and like described by its design specification AHB protocol on chip bus uses universal verification methodology for verification it combines the advantages of OVM and VMM two verification methods it has become the latest verification standard in the chip verification industry UVM offers base class libraries for generating and organizing testbench methodology outlines set of rules and procedures for doing things in a systematic way the main benefit of UVM are wide-ranging base class library support and can perform coverage-driven constraint random verification fully supported by major tool vendors maintained by accellera.





The purpose of building a UVM verification platform is to verify that the functionality of the design under test conforms to the design specifications. The UVM verification platform consists of a series of verification components. For all classes in UVM, there is a common base class, uvm_void, which is an empty shell with neither data members nor member functions. uvm_object is extended from the uvm_void class and serves as the base class for all entities in UVM. Then uvm_object is divided into two



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branches, which evolve into uvm_component through uvm_report_object along the way and various components thereafter uvm_sequence_item and uvm_sequence through uvm_transaction along the way. The classes evolved from these two lines are significantly different. uvm_component exists all the time in the entire simulation, while uvm_transaction can be transient in the entire platform. The two cooperate with each other, and the specific inheritance relationship is shown in Fig.1. All the nodes of uvm tree are composed of uvm_component. Only the derived class based on uvm_component can be the node of UVM tree. The leftmost branch or the class directly derived from uvm_object is not likely to reappear in the form of nodes on the UVM tree. Usually used verification components and their functions in the UVM verification platform are shown in UVM Testbench Architecture.

III. UVM TESTBENCH ARCHITECTURE



Fig. 2. UVM Testbench Architecture

The UVM testbench is developed for the verification and analysis components derived from the UVM base class libraries. The interface is used to define the signals of DUV. It is through this interface that Driver and DUV communicates each other. The virtual interface handle is set to interface instance in top harness module. The testbench generates random vectors and drives the DUV. The stimulus applied as well as DUV response is monitored for checking purposes to verify the DUV functionality. The testbench also uses the coverage mechanism to report functional coverage as a measure to evaluate the progress of verification process. The UVM components along with their functionality are described below:

A. Test

The test instantiates the environment and achieve connection from sequence to sequencer by using start method.

B. Environment

All the UVM verification components are grouped together inside a single container called environment. The verification components can be configured in any arbitrary way by defining an environment. A UVM testbench can have multiple such environments.

C. Agent

The sequencer, driver and monitor are encapsulated into a single entity called agent. Agents can either be active or passive depending on whether it instantiates all the components and stimulate the DUV or only the monitor to track the DUV responses respectively.

D. Sequencer

The sequencer runs the sequence. The sequences generated are send to the driver through sequencer whenever the driver demands for it.



E. Driver

The driver converts the data fields of sequence items into pin level transactions to drive the DUV using a virtual interface.

F. UVM Sequence Item

The data properties such as control, payload, configuration and analysis information of the random stimuli to be applied to the DUV are defined by the sequence item. The input data properties are declared as random variables for constrained random testing.

G. Sequence

The sequence items are generated and randomized by the sequence before transmitting them to the driver. Sequences can be test specific.

H. Monitor

The monitor tracks the activity at pin level of DUV, converts them into transfer level transactions and send them to the scoreboard and coverage collector using the TLM analysis ports.

I. Scoreboard

The scoreboard is used to compare whether the DUV response matches with the expected behaviour. It decides whether a test case has passed or failed.

J. Coverage

The coverage keeps track of all hits occurring on the DUV signals that are specified as cover points in the coverage model during simulation.

K. Assertion

Validates the protocol behaviour at DUT interface and DUT inside contents.

IV.OPERATION OF AHB

A. AHB Master

A master initiates the operation by transferring the address and control information. These control information gives the whether to perform write or read operation.





B. AHB Slave

The slave responds write and read operation to the address and control information which is sent by master. When the HREADY signal is high it indicates the particular transfer is completed, if it is low it means that its performing operation so at this time slave can request the master to place the wait states in order to complete the operation. The RESP signal gives the information whether the operation is OKAY or ERROR/Wait, if the RESP is low it represents the Okay else Error/wait.



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Fig. 4. AHB Slave

V. RESULTS

Questa Sim 10.4e tool is used to simulate and verify the AHB protocol and the simulation results are analysed to evaluate the effectiveness of the proposed testbench. Functional coverage and assertion are achieved as per the verification plans.



Fig. 5. Write transfer simulation result



Fig. 6. Read transfer simulation result

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Fig. 7. Write and read transfer with wait simulation result



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Fig. 8. Transfer type simulation result



Fig. 9. Burst write transaction simulation result



Fig. 10. Burst read transaction simulation result



Fig. 11. Coverage and Assertion report display

VI.CONCLUSIONS

In this project verification of AMBA AHB Protocol has been verified by using the UVM methodology. We have used UVM to put up a verification environment which focuses on functional verification in order to check the correctness of the AHB. The test bench accomplished complete functional verification of AHB and achieved 100% coverage through systematic execution of



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relevant testcases and assertion are achieved. The simulation waveform demonstrates the successful exchange of data between AHB master and AHB slave.

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